

FIG. 1

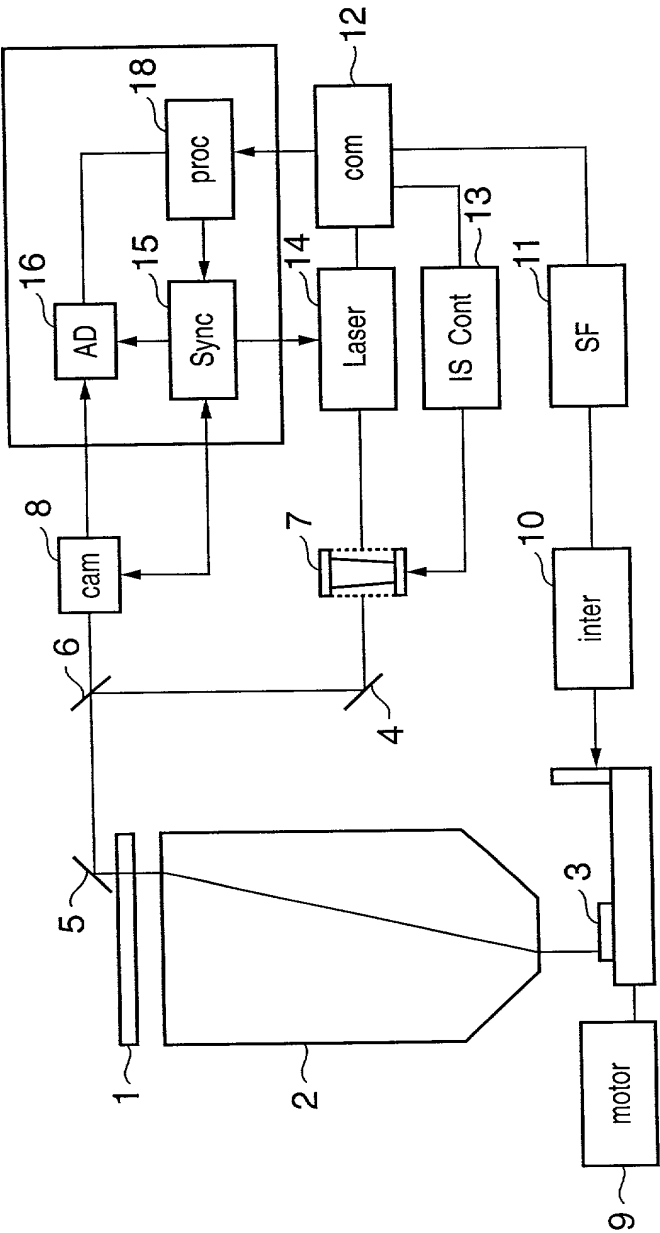


FIG. 2

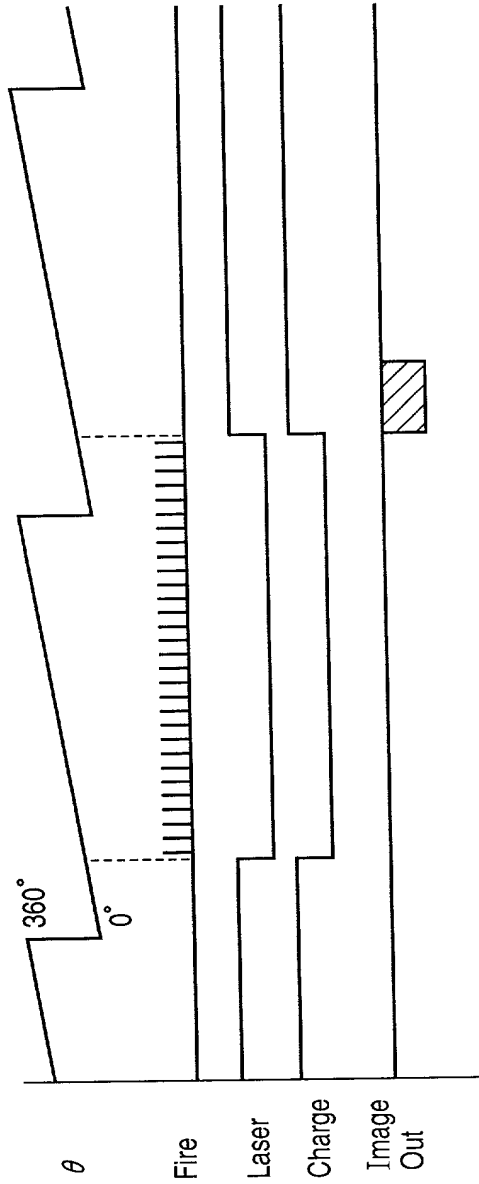
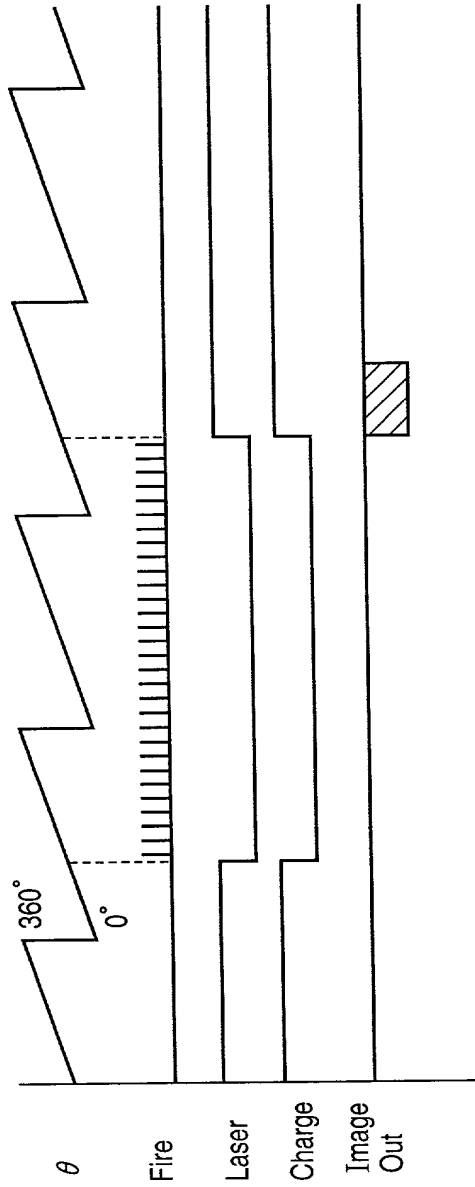


FIG. 3



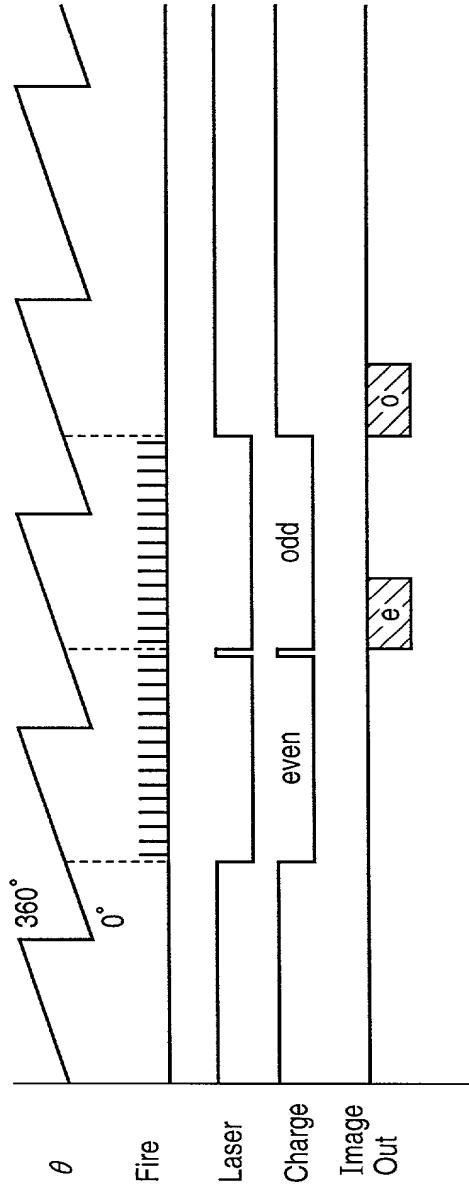
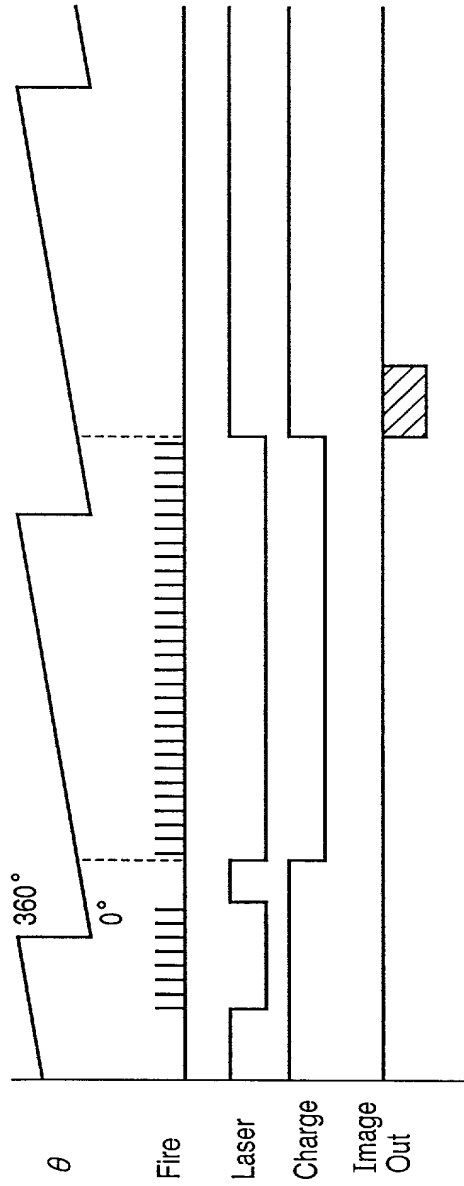
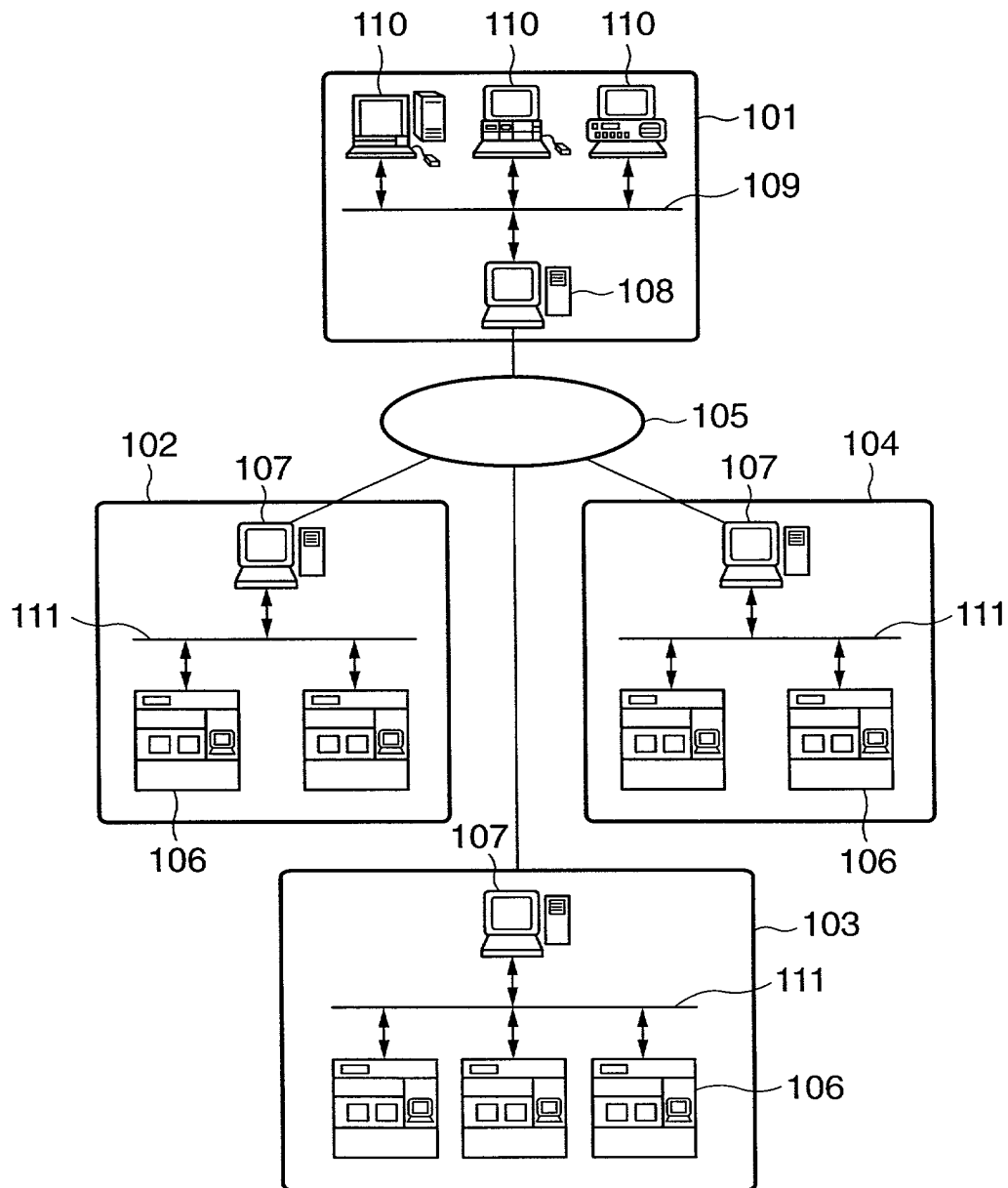
**FIG. 4**

FIG. 5



**FIG. 6**

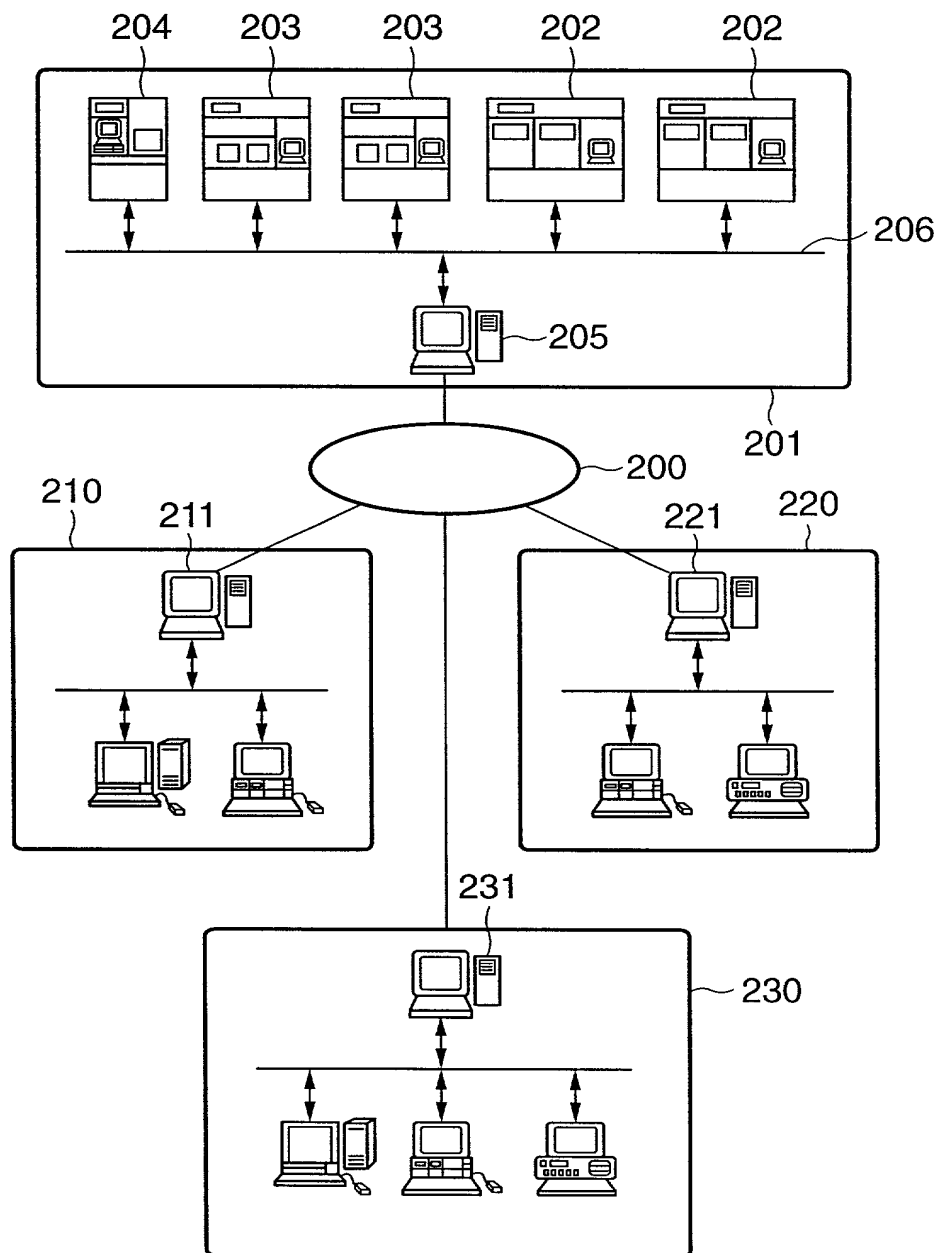
**FIG. 7**

FIG. 8

URL

TROUBLE DB INPUT SCREEN

DATE OF OCCURRENCE  404

MODEL  401

SUBJECT  403

APPARATUS S/N  402

URGENCY  405

SYMPTOM  406

REMEDY  407

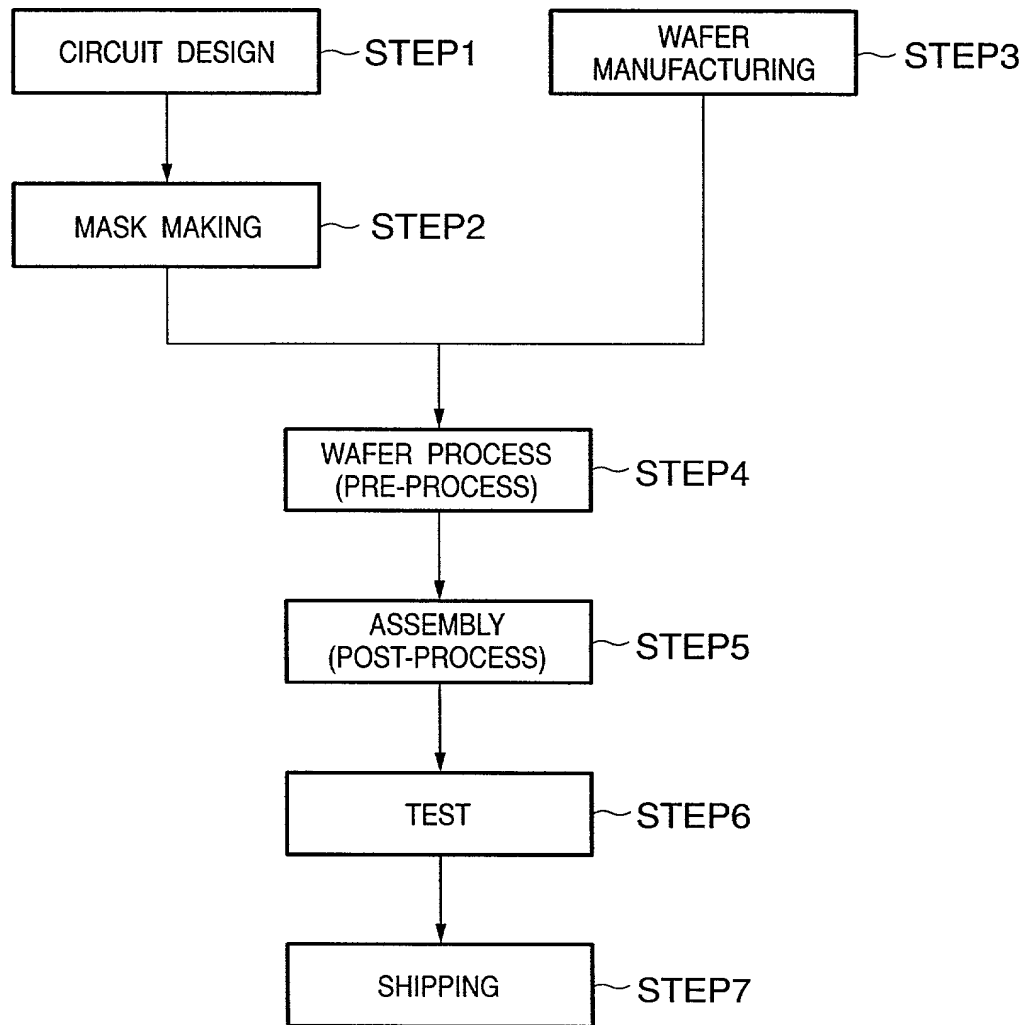
PROGRESS  408

410

411

412



**FIG. 9**

MANUFACTURE FLOW OF SEMICONDUCTOR DEVICE

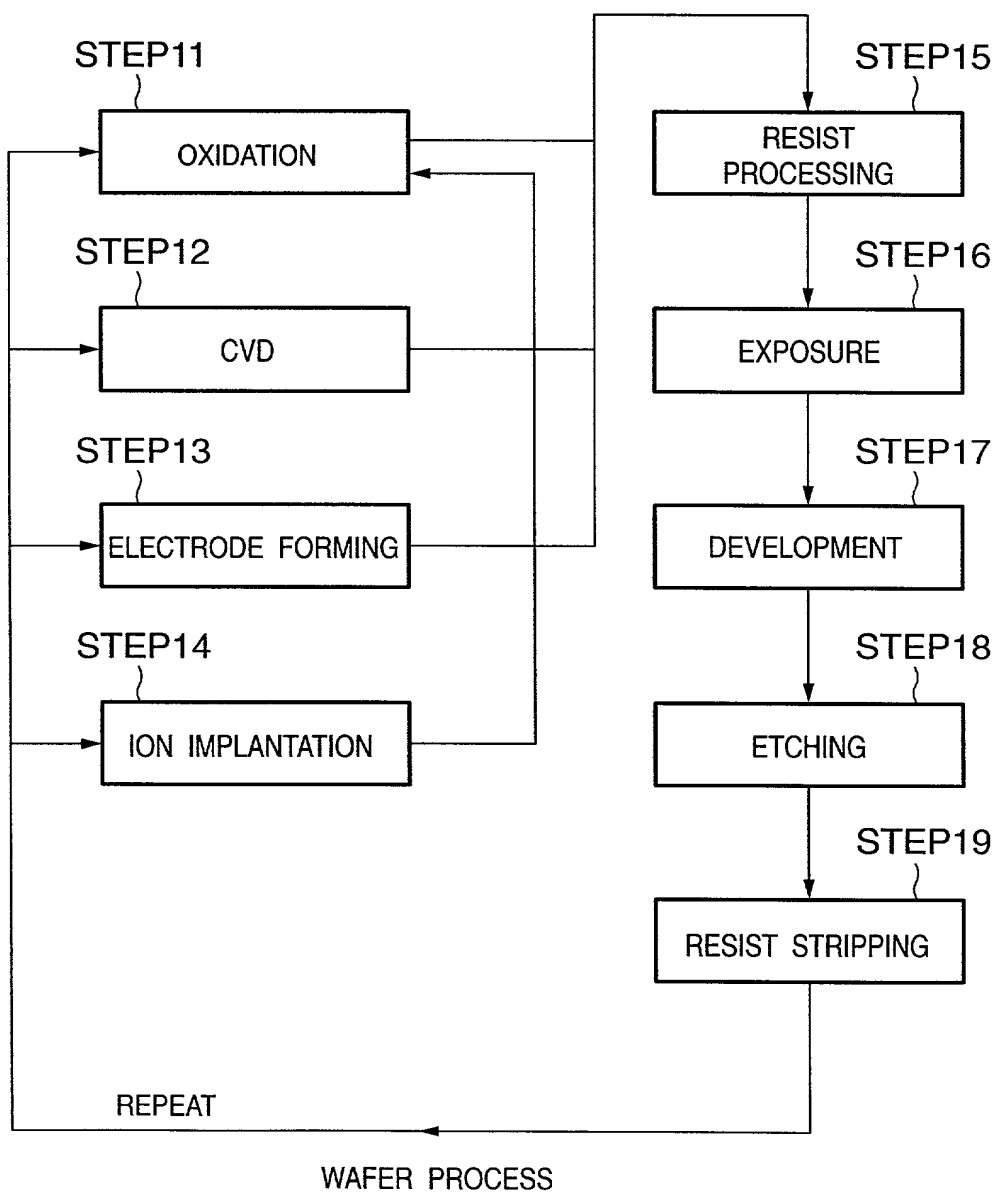
**FIG. 10**

FIG. 11

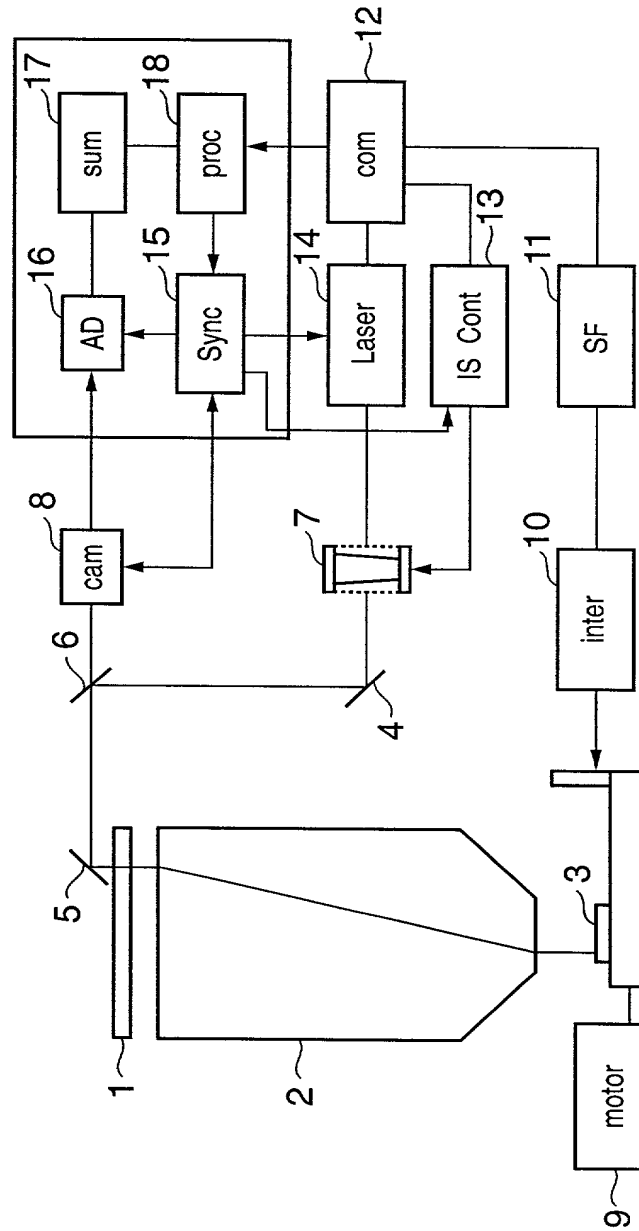


FIG. 12

